



# QPD1011A

## 7W, 50V, 30 – 1200MHz, GaN Input Matched Transistor

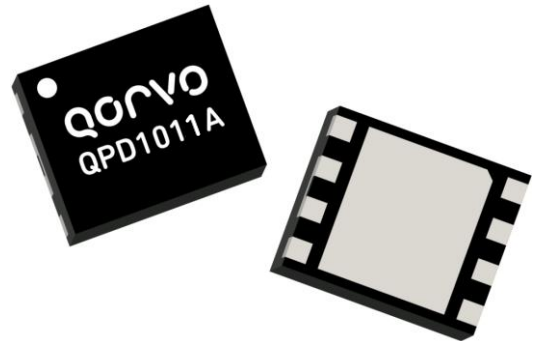
### 1. Product Overview and Benefits

The Qorvo QPD1011A is a 7W ( $P_{3dB}$ ), 50 $\Omega$  input matched discrete GaN on SiC HEMT which operates from 30 MHz to 1200 MHz. The integrated input matching network enables wideband gain and power performance, while the output can be matched on board to optimize power and efficiency for any region within the band.

The device is housed in a 6 x 5 mm leadless SMT package that saves real estate of already space-constrained handheld radios.

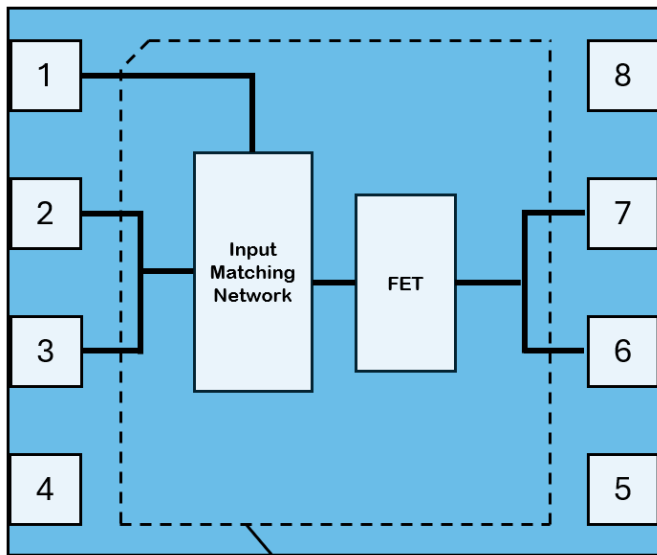
Lead-free and ROHS compliant.

Evaluation boards are available upon request.



6 x 5 x 0.85mm DFN Package

### 2. Functional Block Diagram



Package Backside  
Ground Pad Pin 9

Top View

### 3. QPD1011AEVB Performance

Freq.(GHz)	$P_{3dB}$ (W)	$G_{3dB}$ (dB)	$DE_{3dB}$ (%)
0.1	11.2	13.4	51.7
0.5	10.2	14.6	60.9
1.0	8.3	13.4	43.7

At Bottom of Baseplate Temperature of 25°C, Signal Type: CW

$V_D = 50V$ ,  $I_{DQ} = 20mA$

See [Evaluation Board – 100 – 1000MHz](#) for more details.

### 4. Key Features

- Operating Voltage: 50V
- Low Thermal Resistance Package
- CW and Pulse Capable
- 6 x 5mm Package

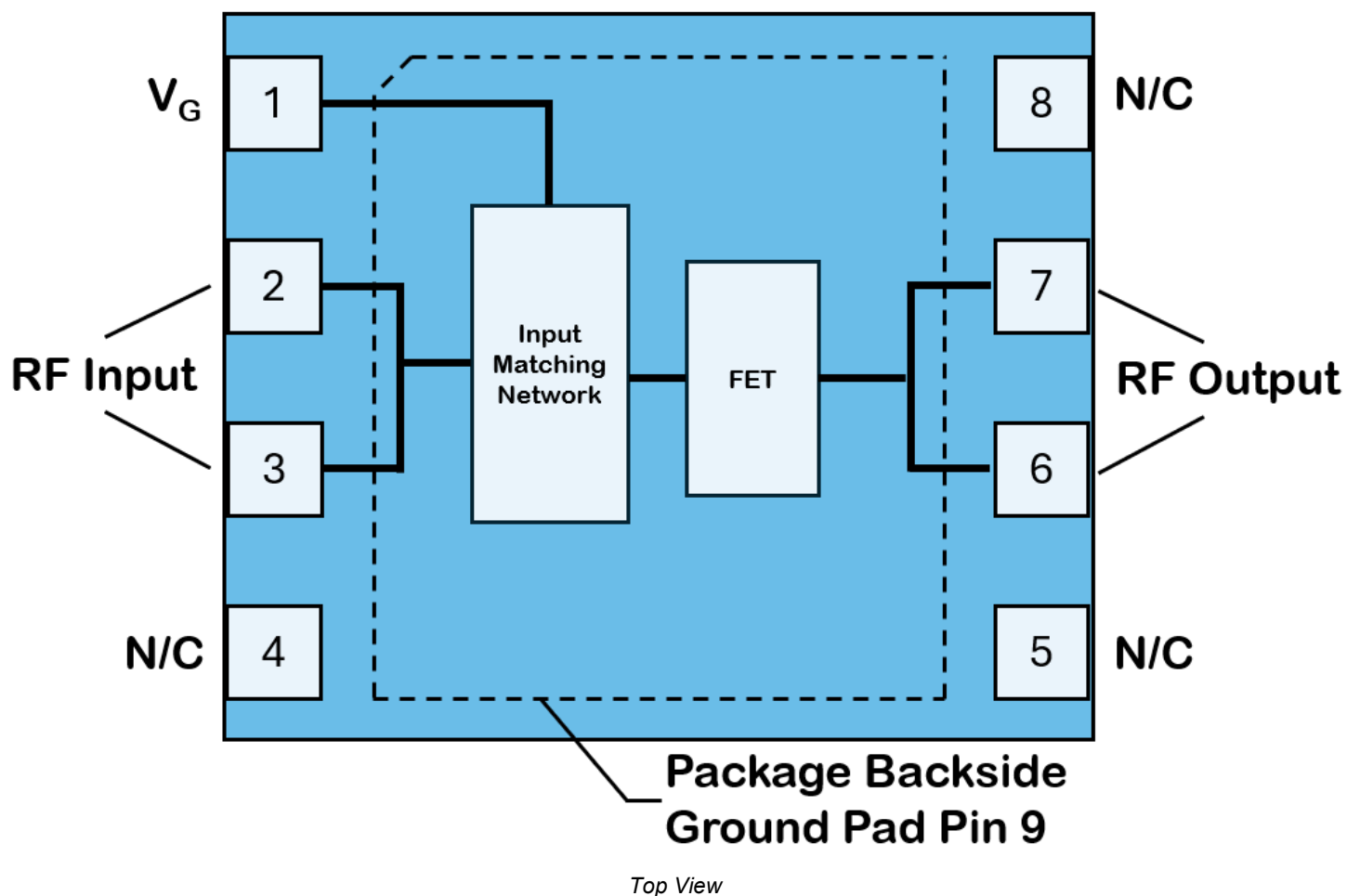
### 5. Applications

- Military Radar
- Civilian Radar
- Land mobile and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers

### 6. Ordering Information

Part Number	Description
QPD1011AS2	2 pcs. WP Sample
QPD1011ASR	100 pcs. 7" Short Reel
QPD1011ATR7	750 pcs. 7" Reel
QPD1011AEVB	100 – 1000MHz Evaluation Board

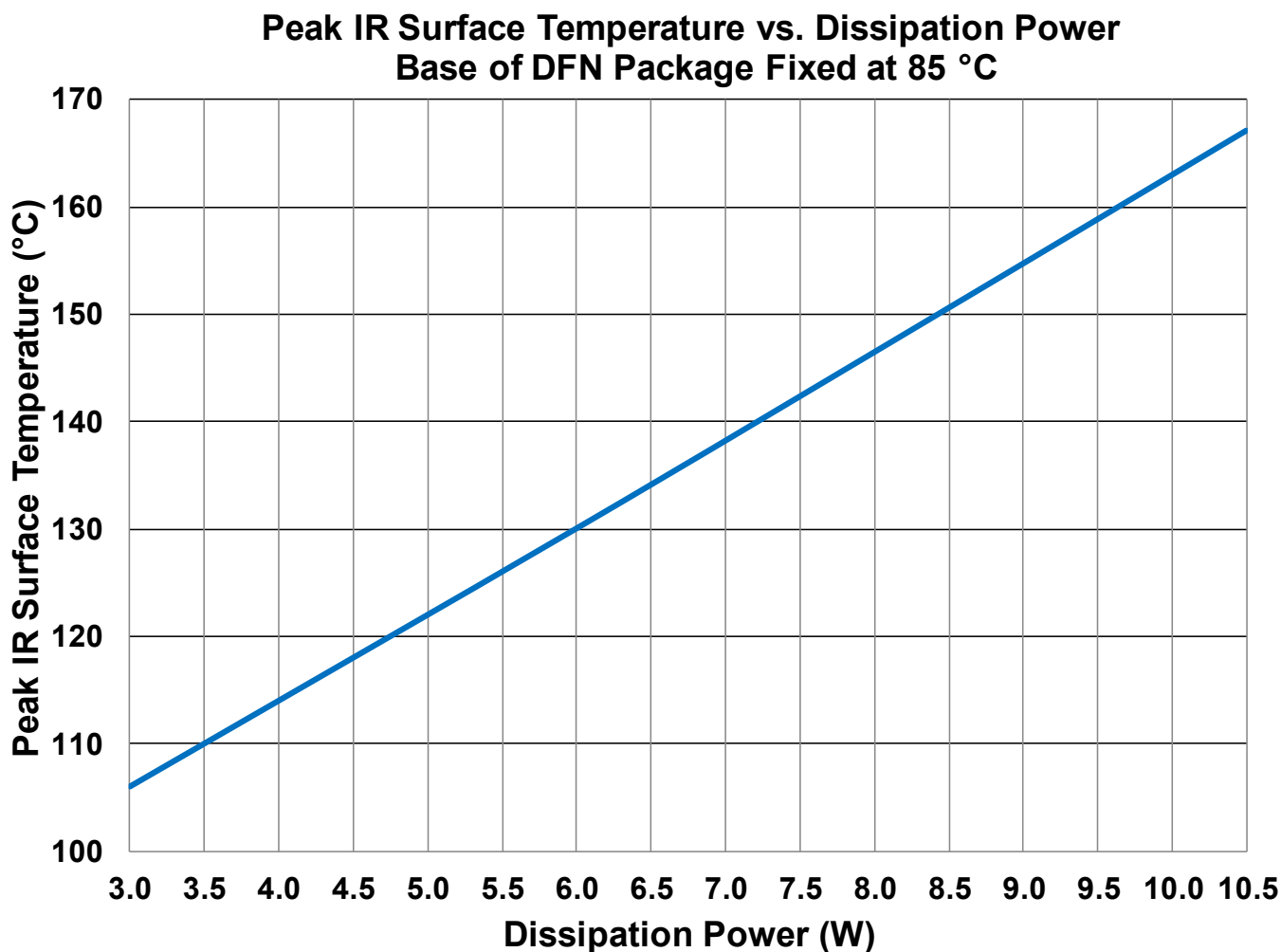
## 7. Pin Configuration and Description



Pin Number	Label	Description
1	$V_G$	Gate Supply
2, 3	$RF_{IN}$	RF Input Port 50 OHM
6, 7	$RF_{OUT}$	Drain Supply, RF Output Port
9	GND	Ground Pad
4, 5, 8	N/C	No connections required. Can be used for reflow alignment.

## 8. Thermal and Reliability Information

### 8.1. Pulsed Continuous Wave

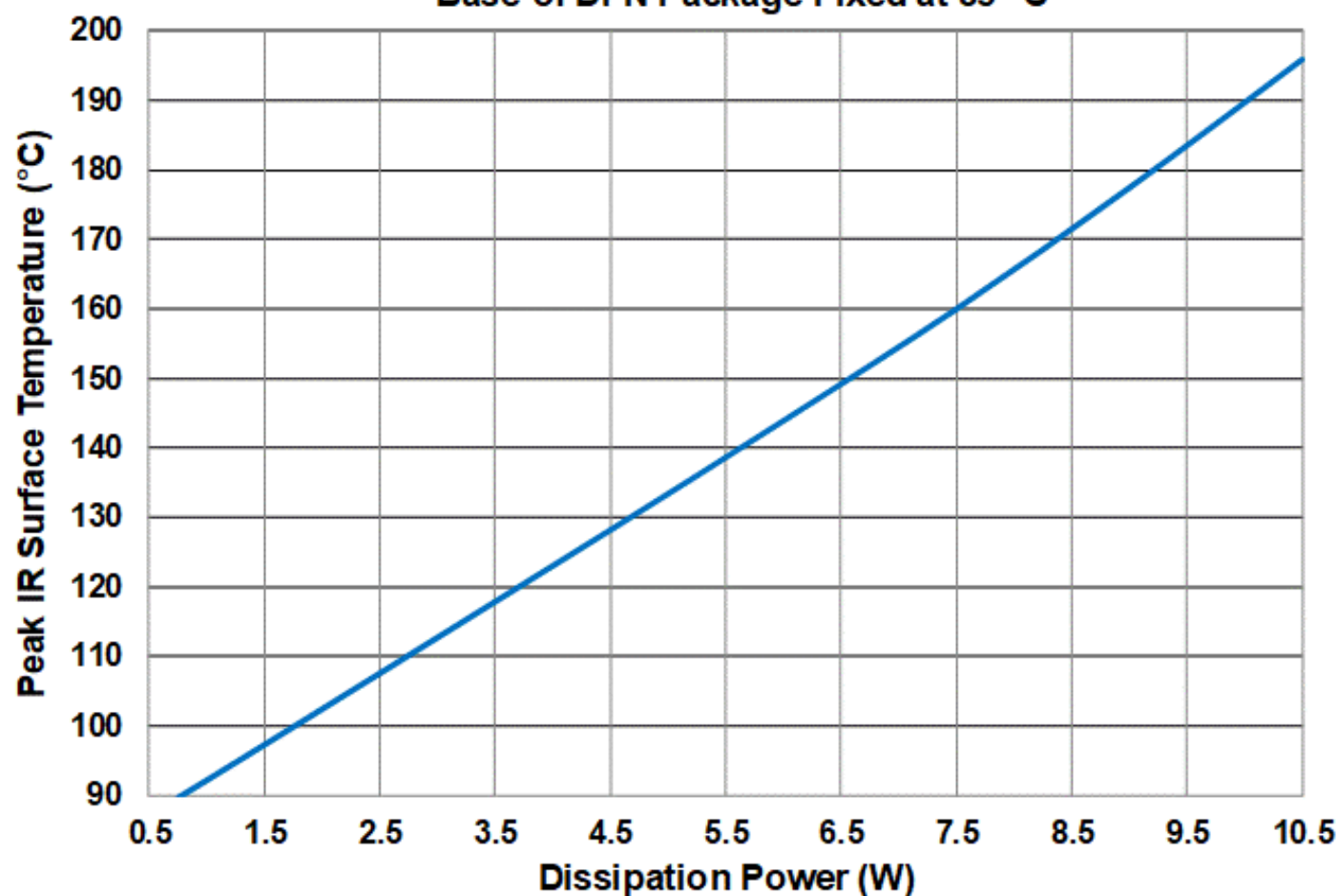


Parameter	Conditions	Values	Unit
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	7.0	°C/W
Peak IR Surface Temperature, $T_{CH}$	3.0 W Pdiss, Pulse Width = 100us, Duty Cycle = 10%	106	°C
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	7.5	°C/W
Peak IR Surface Temperature, $T_{CH}$	6.0 W Pdiss, Pulse Width = 100us, Duty Cycle = 10%	130	°C
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	7.7	°C/W
Peak IR Surface Temperature, $T_{CH}$	8.3 W Pdiss, Pulse Width = 100us, Duty Cycle = 10%	149	°C
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	7.8	°C/W
Peak IR Surface Temperature, $T_{CH}$	10.5 W Pdiss, Pulse Width = 100us, Duty Cycle = 10%	167	°C

Please refer to the following document [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

## 8.2. Continuous Wave

**Peak IR Surface Temperature vs. CW Dissipation Power**  
**Base of DFN Package Fixed at 85 °C**



Parameter	Conditions	Values	Unit
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	9.6	°C/W
Peak IR Surface Temperature, $T_{CH}$	4.5 W Pdiss, CW	128	°C
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	9.8	°C/W
Peak IR Surface Temperature, $T_{CH}$	6.0 W Pdiss, CW	144	°C
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	10.0	°C/W
Peak IR Surface Temperature, $T_{CH}$	7.5 W Pdiss, CW	160	°C
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	10.2	°C/W
Peak IR Surface Temperature, $T_{CH}$	9.0 W Pdiss, CW	177	°C
IR Thermal Resistance, $\theta_{JC}$	85°C backside temperature	10.6	°C/W
Peak IR Surface Temperature, $T_{CH}$	10.5 W Pdiss, CW	196	°C

Please refer to the following document [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)



## 9. Electrical Characteristics

### 9.1. Absolute Maximum Ratings

Parameter	Rating	Unit
Breakdown Voltage, $BV_{DG}$	+145	V
Gate Voltage Range, $V_G$	-7 to +2	V
Drain Current	1.46	A
Gate Current Range, $I_G^2$	3.6	mA
Power Dissipation, $P_{DISS}^1$	14.7	W
RF Input Power, $P_{IN}^1$	+27	dBm
Mounting Temperature (30 Seconds)	320	°C
Storage Temperature	-65 to +150	°C

Operation of this device outside the parameter ranges given above may cause permanent damage.

Note:

1. Pulsed Continuous Wave(Pulsed CW) Pulse Width = 100us Duty Cycle = 10%,  $T = 25^{\circ}\text{C}$ , 1GHz
2. At FEA Channel Temperature of  $200^{\circ}\text{C}$

### 9.2. Recommended Operating Conditions

Parameter	Min.	Typ.	Max.	Units
Operating Temperature Range	-40	+25	+85	°C
Drain Voltage Range, $V_D$	+12	+50	+55	V
Drain Bias Current, $I_{DQ}$	-	20	-	mA
Gate Voltage, $V_G^1$	-	-2.8	-	V
Channel Temperature ( $T_{CH}$ )	-	-	+250	°C
Power Dissipation, CW ( $P_{DISS}$ ) <sup>2</sup>	-	-	10	W

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Note:

1. To be adjusted to desired  $I_{DQ}$
2. Back side of package at  $85^{\circ}\text{C}$

### 9.3. Load Pull Performance – Power Tuned

Parameters	Typical Values				Unit
Frequency, Freq.	0.6	0.8	1.0	1.2	GHz
Linear Gain, $G_{LIN}$	18.7	21	21.3	19.6	dB
Output Power at 3dB Compression, $P_{3dB}$	39.7	39.4	39.4	39.1	dBm
Power Added Efficiency at 3dB Compression, $PAE_{3dB}$	59.4	58.7	49.3	49.1	%
Gain at 3dB Compression	15.7	18	18.3	16.6	dB

Note:

1. Test conditions: Pulsed Continuous Wave(Pulsed CW), Pulse Width = 100us, Duty Cycle = 10%,  $V_D = +50\text{V}$ ,  $I_{DQ} = 25\text{mA}$ , Temperature =  $+25^{\circ}\text{C}$ .



9.4. Load Pull Performance – Efficiency Tuned

Parameters	Typical Values				Unit
Frequency, Freq.	0.6	0.8	1.0	1.2	GHz
Linear Gain, G <sub>LIN</sub>	20.9	22.2	22.5	22.1	dB
Output Power at 3dB Compression, P <sub>3dB</sub>	37.7	38.4	37.3	37.4	dBm
Power Added Efficiency at 3dB Compression, PAE <sub>3dB</sub>	71.6	64.1	60.1	55.4	%
Gain at 3dB Compression	17.9	19.2	19.5	19.1	dB

Note:

1. Test conditions: Pulsed Continuous Wave(Pulsed CW), Pulse Width = 100us, Duty Cycle = 10%, V<sub>D</sub> = +50V, I<sub>DQ</sub> = 25mA, Temperature = +25°C.



# QPD1011A

## 7W, 50V, 30 – 1200MHz, GaN Input Matched Transistor

### 9.5. RF Characterization – 100 – 1000 MHz EVB Performance at 900MHz

Parameter	Min	Typ	Max	Units
Linear Gain, $G_{LIN}$	-	18.7	-	dB
Output Power at 3dB Compression, $P_{3dB}$	-	39.9	-	dBm
Drain Efficiency at 3dB Compression, $DE_{3dB}$	-	51.5	-	%
Gain at 3dB Compression, $G_{3dB}$	-	15.7	-	dB

Notes:

1. Test conditions unless otherwise noted:  $V_D = +50V$ ,  $I_{DQ} = 20mA$ , Continuous Wave(CW), Bottom of Baseplate Temp = 25°C.

### 9.6. RF Characterization – Mismatch Ruggedness at 1000 MHz

Symbol	Parameter	dB Compression	Typical
VSWR	Impedance Mismatch Ruggedness	3	10:1

Notes:

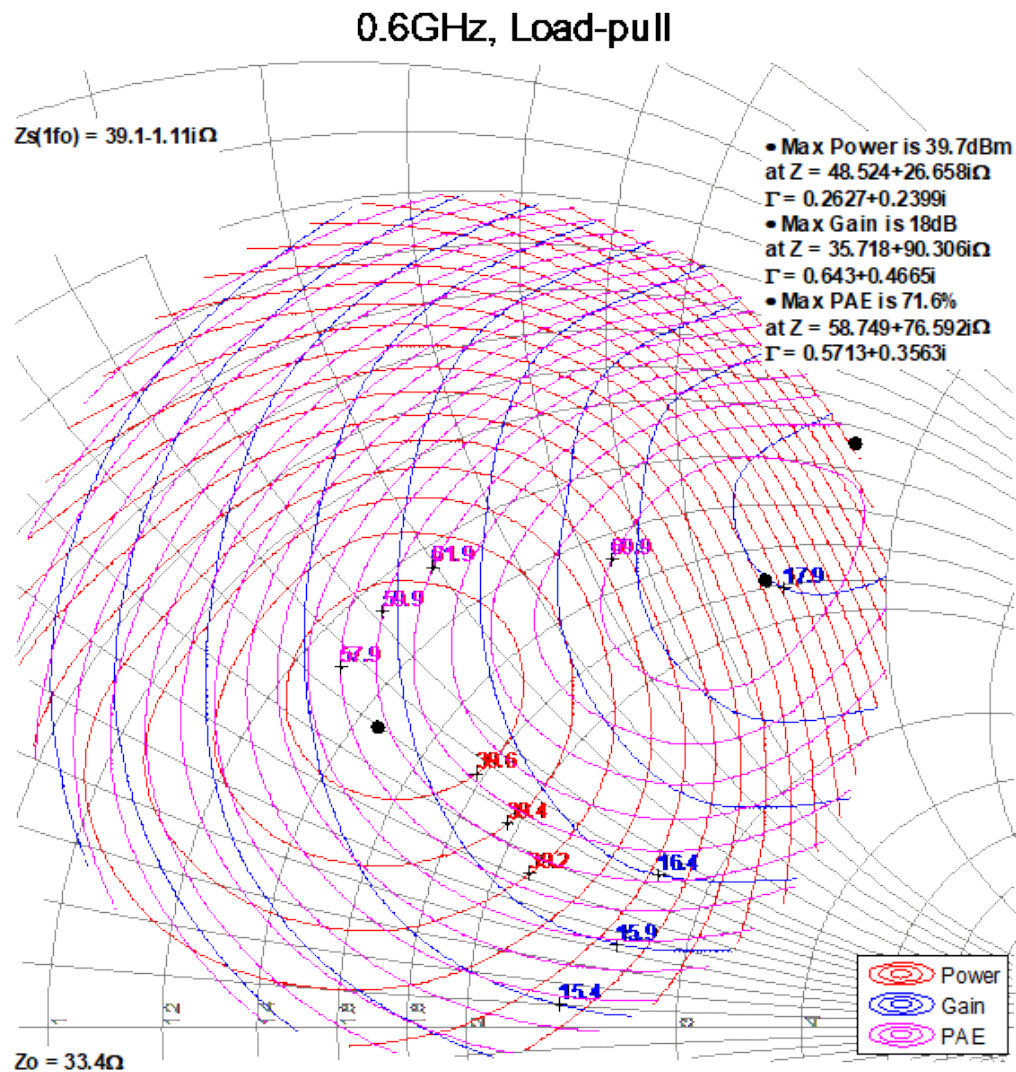
1. Test conditions unless otherwise noted: Bottom of Baseplate Temp = 25°C,  $V_D = 50V$ ,  $I_{DQ} = 20mA$ , Continuous Wave(CW). Driving input power is determined at CW compression under matched condition at EVB output connector.

### 9.7. Load Pull Contours

#### 9.7.1. 600MHz

Notes:

1.  $V_D = 50V$ ,  $I_{DQ} = 20mA$ , Pulsed CW, Pulse Width = 100us, Duty Cycle = 10%. Performance is at 3dB compression referenced to peak gain.
2. See [Recommended Package Footprint](#) for load pull and source pull reference planes. 50OHM load pull fixtures are built with 20-mil RO4350B material.
3. NaN means the impedances are either undefined or varying in load pull system.

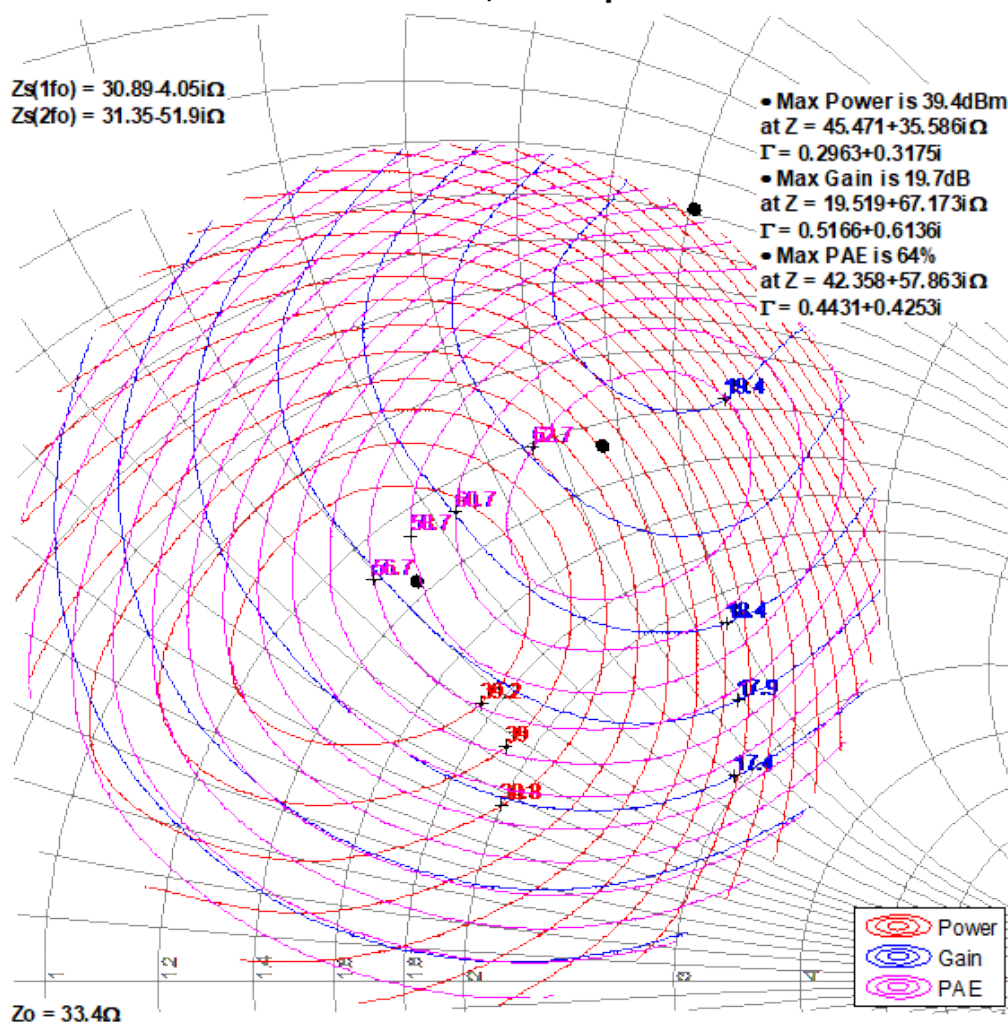


### 9.7.2. 800MHz

#### Notes:

1.  $V_D = 50V$ ,  $I_{DQ} = 20mA$ , Pulsed CW, Pulse Width = 100us, Duty Cycle = 10%. Performance is at 3dB compression referenced to peak gain.
2. See [Recommended Package Footprint](#) for load pull and source pull reference planes. 50OHM load pull fixtures are built with 20-mil RO4350B material.
3. NaN means the impedances are either undefined or varying in load pull system.

### 0.8GHz, Load-pull

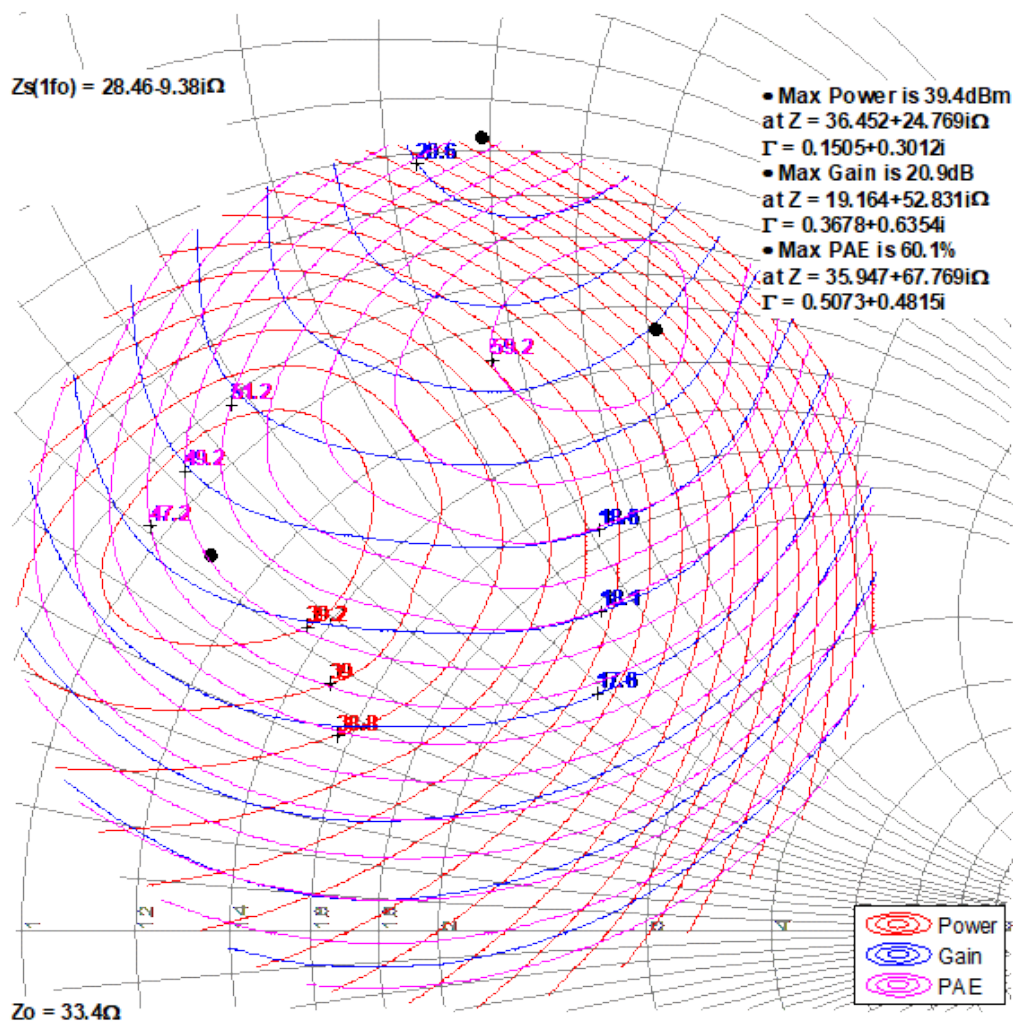


### 9.7.3. 1000MHz

#### Notes:

1.  $V_D = 50V$ ,  $I_{DQ} = 20mA$ , Pulsed CW, Pulse Width = 100us, Duty Cycle = 10%. Performance is at 3dB compression referenced to peak gain.
2. See [Recommended Package Footprint](#) for load pull and source pull reference planes. 50OHM load pull fixtures are built with 20-mil RO4350B material.
3. NaN means the impedances are either undefined or varying in load pull system.

### 1GHz, Load-pull

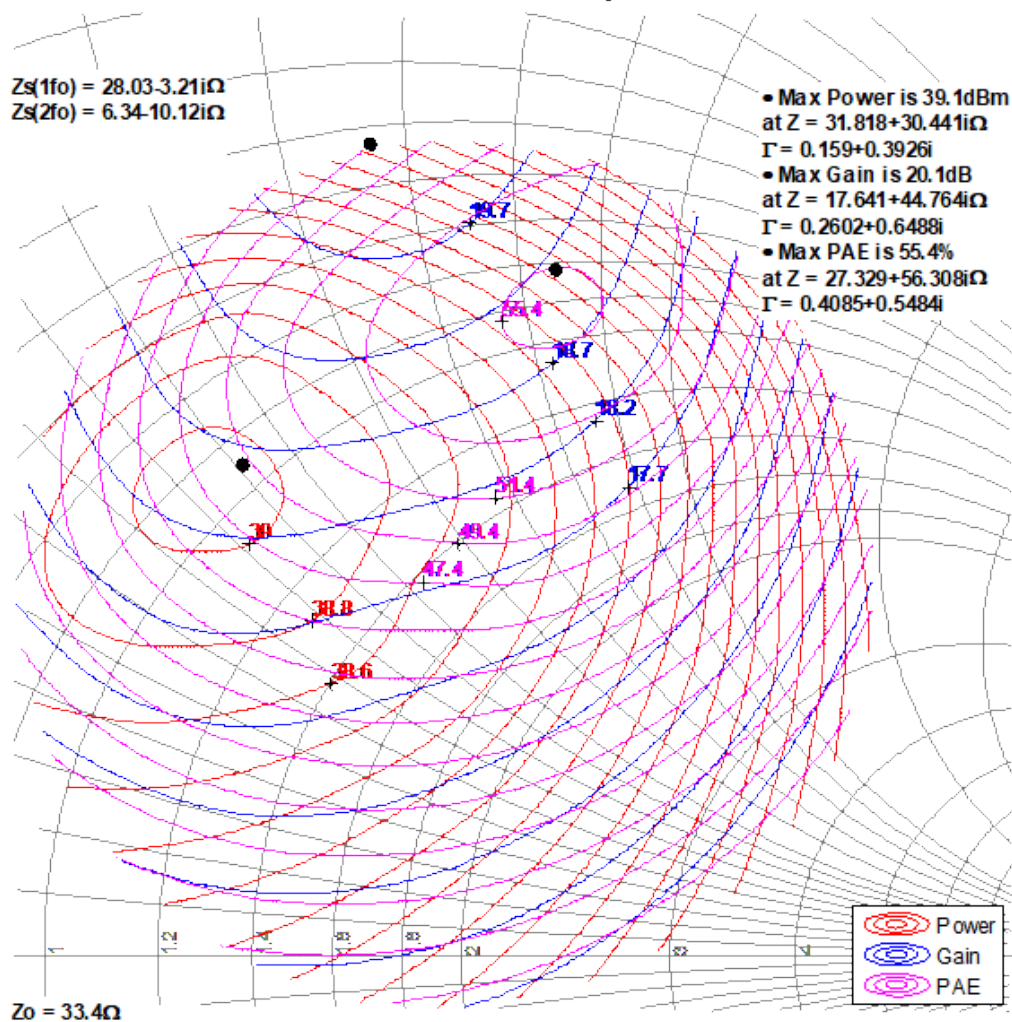


### 9.7.4. 1200MHz

#### Notes:

1.  $V_D = 50V$ ,  $I_{DQ} = 20mA$ , Pulsed CW, Pulse Width = 100us, Duty Cycle = 10%. Performance is at 3dB compression referenced to peak gain.
2. See [Recommended Package Footprint](#) for load pull and source pull reference planes. 50OHM load pull fixtures are built with 20-mil RO4350B material.
3. NaN means the impedances are either undefined or varying in load pull system.

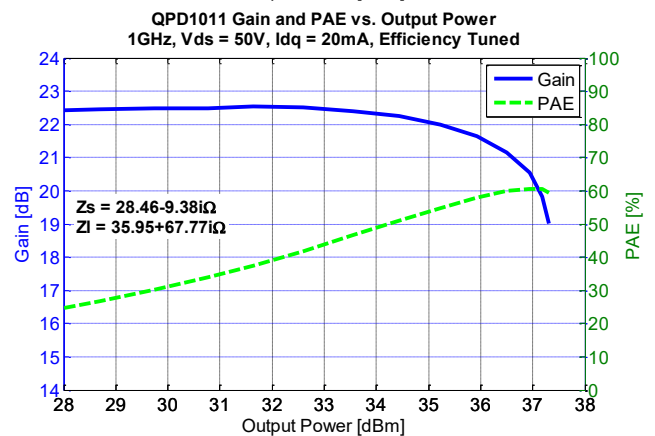
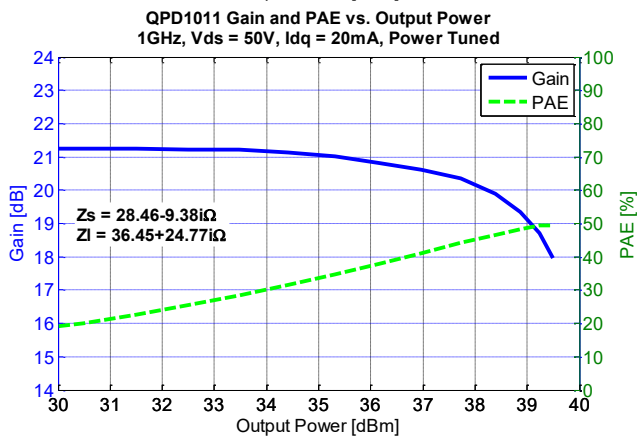
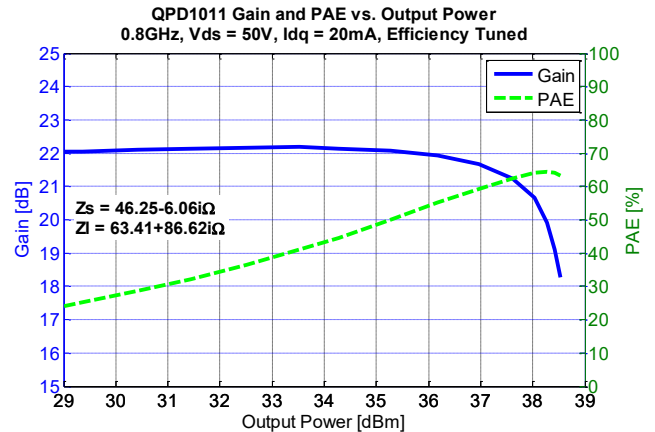
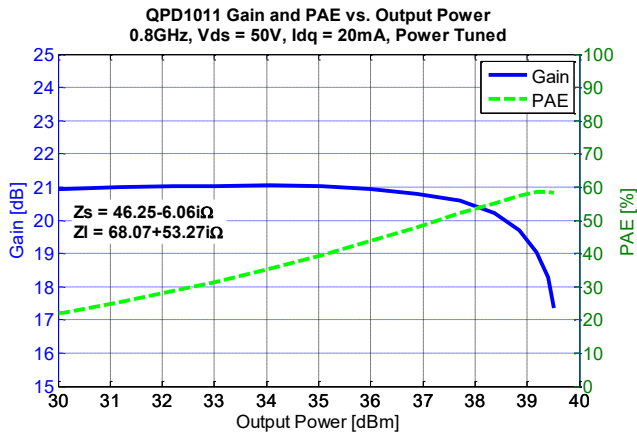
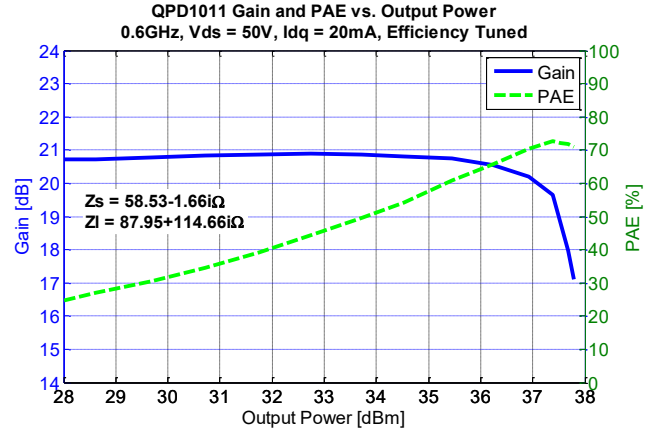
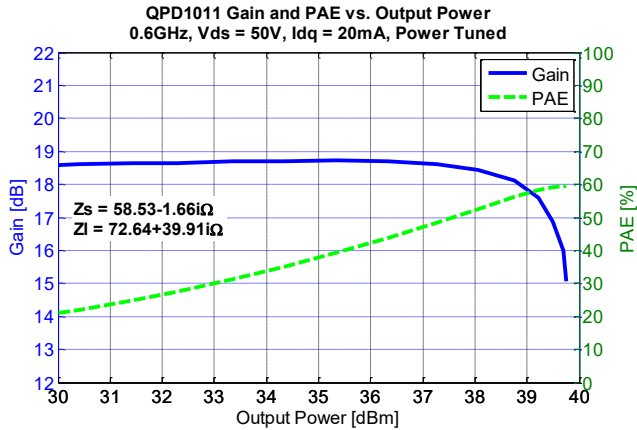
### 1.2GHz, Load-pull



### 9.8. Load Pull Drive-up<sup>1,2</sup>

Notes:

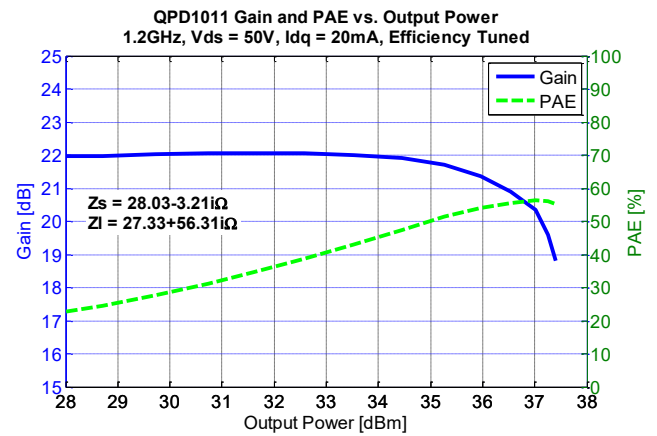
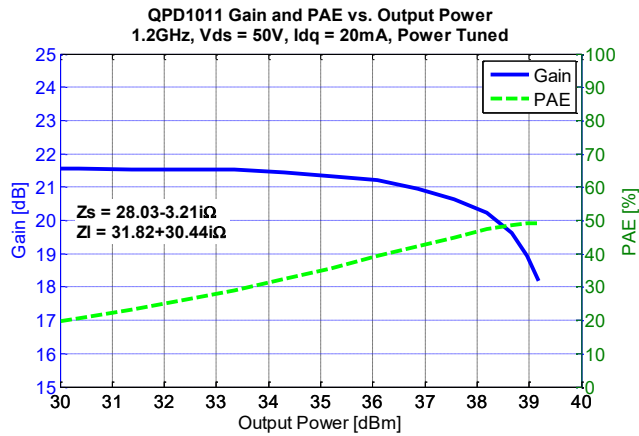
1. Pulsed CW, Pulse Width = 100us, Duty Cycle = 10%,  $V_D = 50V$ ,  $I_{DQ} = 20mA$
2. See [Recommended Package Footprint](#) for load pull and source pull reference planes where the performance was measured.





# QPD1011A

7W, 50V, 30 – 1200MHz, GaN Input Matched Transistor

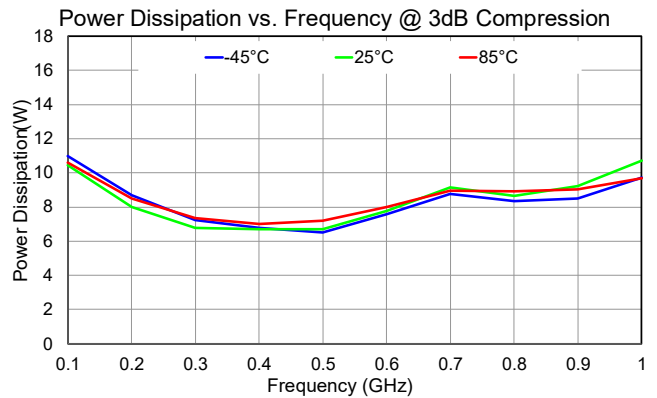
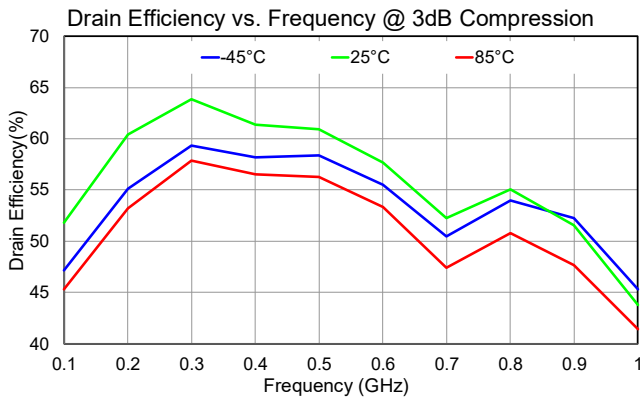
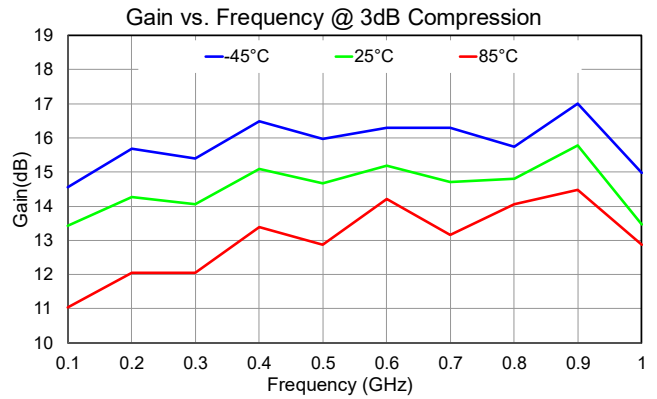
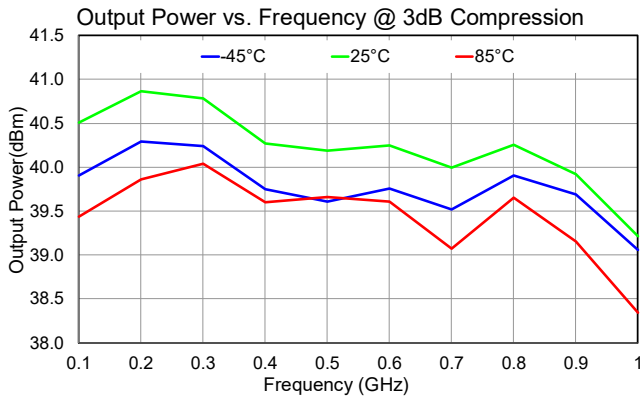


## 10. Evaluation Board – 100 – 1000MHz

### 10.1.1. Power Drive-up Performance Over Temperature

Notes:

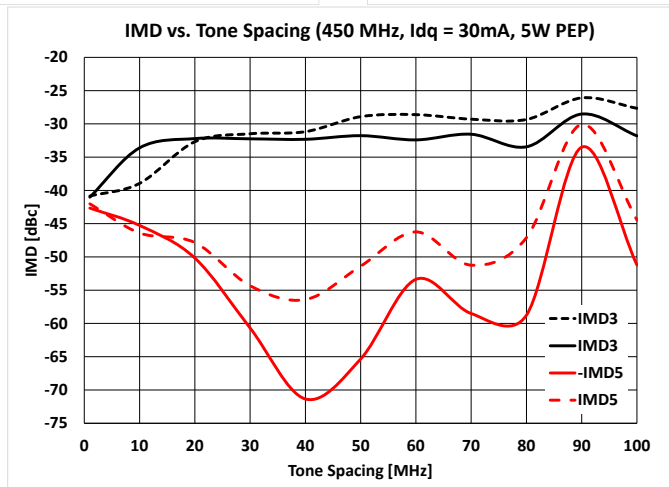
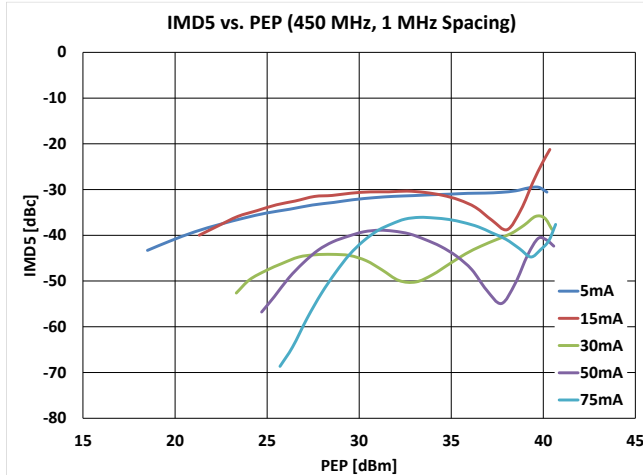
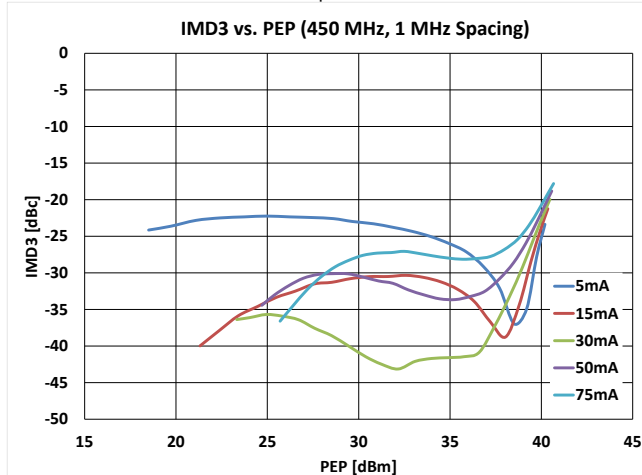
1.  $V_D = 50V$ ,  $I_{DQ} = 20mA$ , Continuous Wave(CW)



### 10.1.2. Two-Tone Performance at 25°C

Notes:

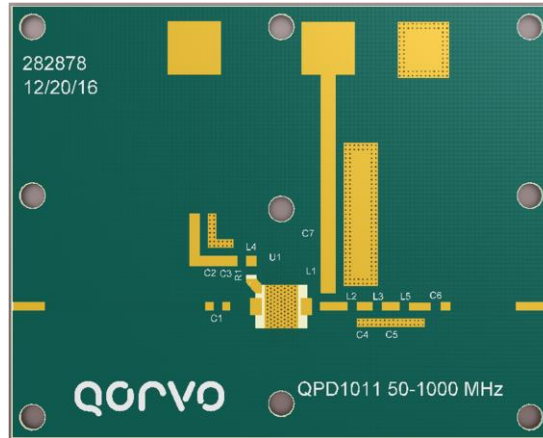
1. Data based on QPD1011A's predecessor: QPD1011 50 – 1000MHz Evaluation Board.



### 10.1.3. PCB Layout – 100 – 1000MHz

Notes:

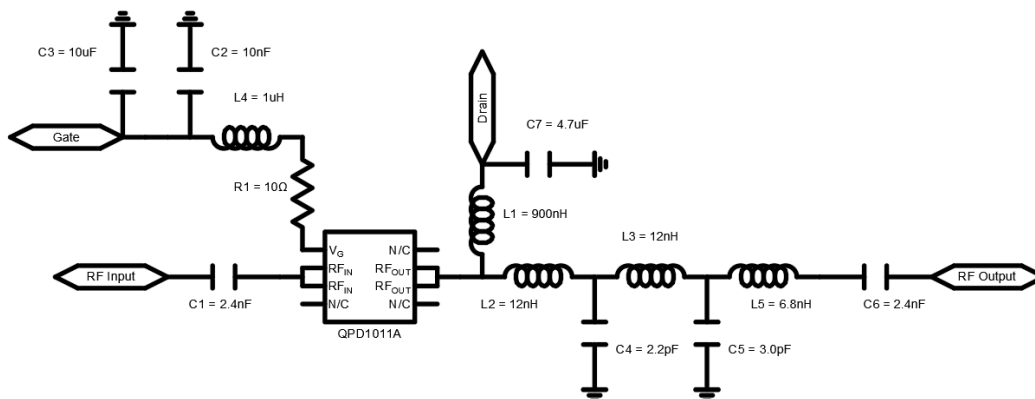
1. PCB Material: RO4350B, 20mil thickness, 2oz copper cladding. Overall EVB size is 3.98" x 3.98".



### 10.1.4. Bill of Material

Reference Designator	Value	Quantity	Manufacturer	Part Number
C2	10 nF	1	AVX Corporation	0603YC103KAT2A
C3	10 uF	1	Murata	GRM21BR71A106KE51L
C1, C6	2400 pF	2	Knowles Novacap	C08BL242X-5UN-X0T
C7	4.7 uF	1	Murata	GRM55ER72A475KA01L
C4	2.2 pF	1	ATC	600S2R2BT250T
C5	1.0 pF	1	ATC	600S3R0BT250XT
R1	10 OHM	1	TTI Inc.	CRCW060310R0JNEA
L4	1000 nH	1	Coilcraft Inc.	0603LS-102XGLC
L1	900 nH	1	Coilcraft Inc.	1008AF-901XJLC
L5	6.8 nH	1	Coilcraft Inc.	0603HC-6N8XJLW
L2, L3	12 nH	2	Coilcraft Inc.	0603HC-12NXGLW

### 10.1.5. Circuit Schematic



# 11. Application Information

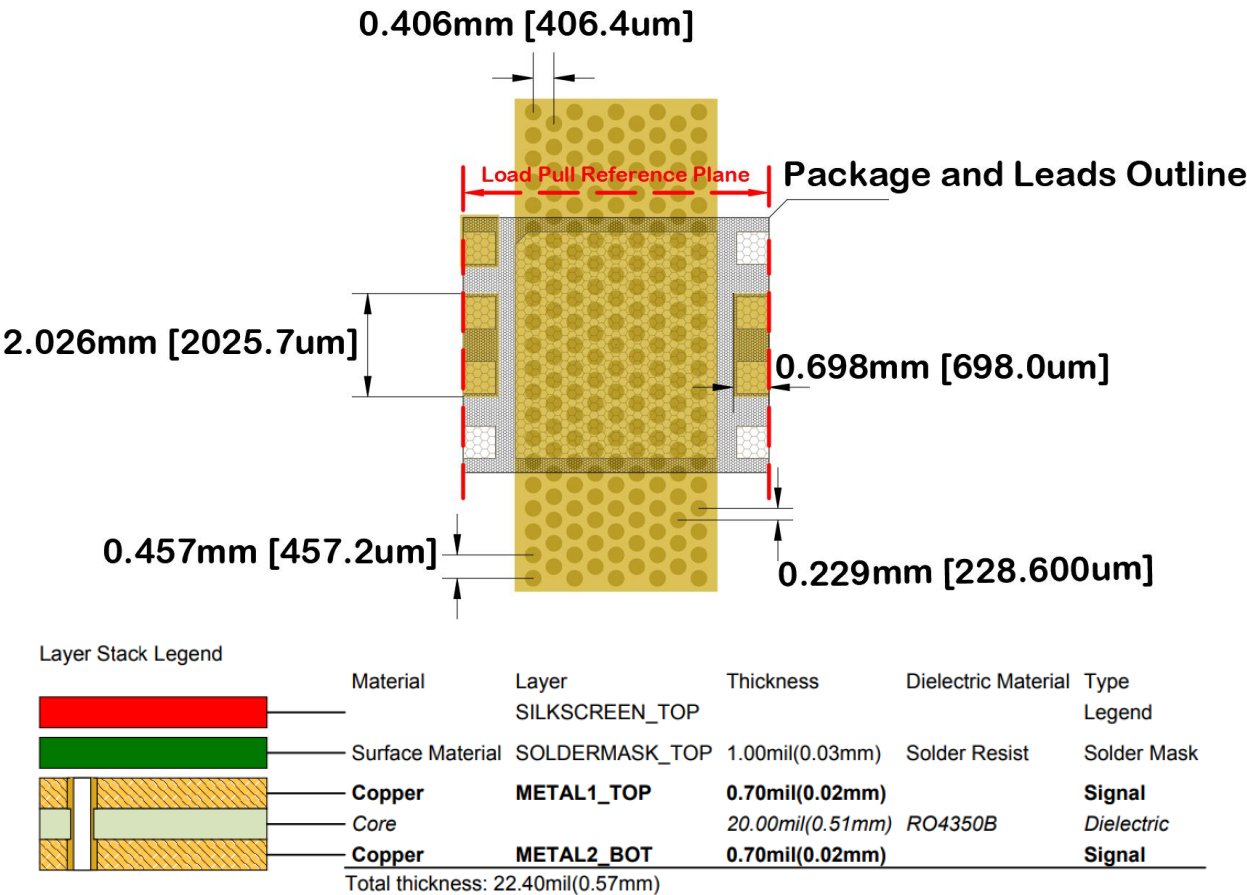
## 11.1. Biasing Sequence

Bias Up Sequence	Bias Down Sequence
1. Set $V_G$ to -5V	1. Turn off RF
2. Set $I_D$ current limit to 40mA	2. Set $V_G$ to -5V
3. Set $V_D$ to 50V	3. Set $V_D$ to 0V
4. Slowly adjust $V_G$ until $I_{DQ}$ is set to 20mA	4. Wait until drain voltage supplying the device is discharged to 0V
5. Set $I_D$ current limit to 1A	5. Turn off Drain Supply
6. Apply RF	6. Turn off Gate Supply

Note:

- The above biasing sequence is based on typical biasing condition of  $V_D = 50V$ ,  $IDQ = 20mA$

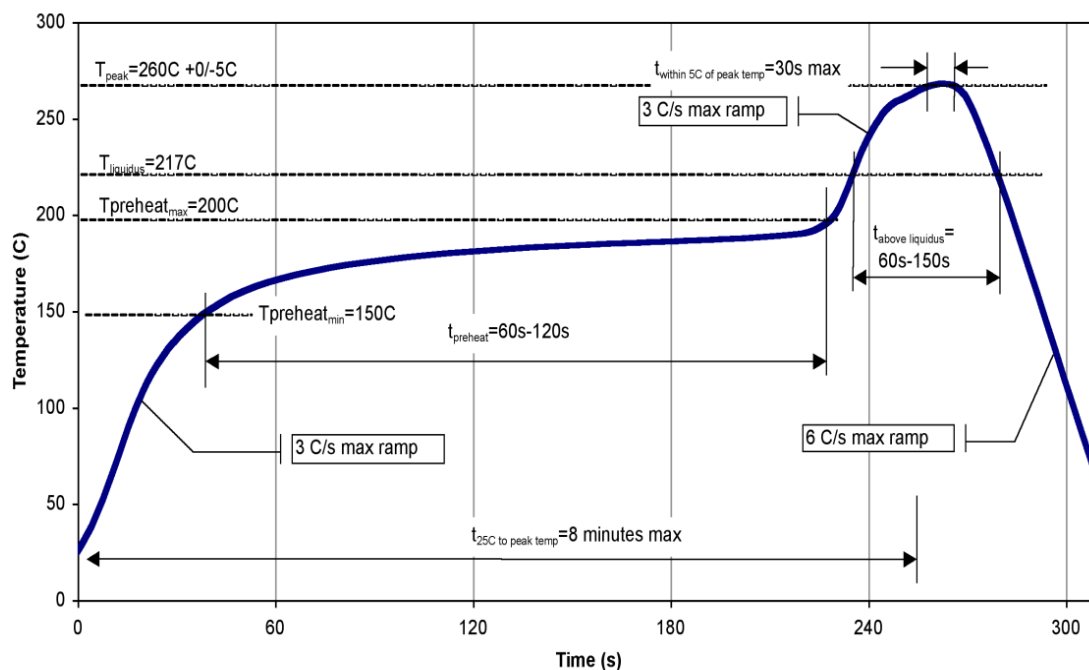
## 11.2. Recommended Package Footprint



Note:

- All vias shown in the package footprint are copper filled.

### 11.3. Recommended Solder Temperature Profile

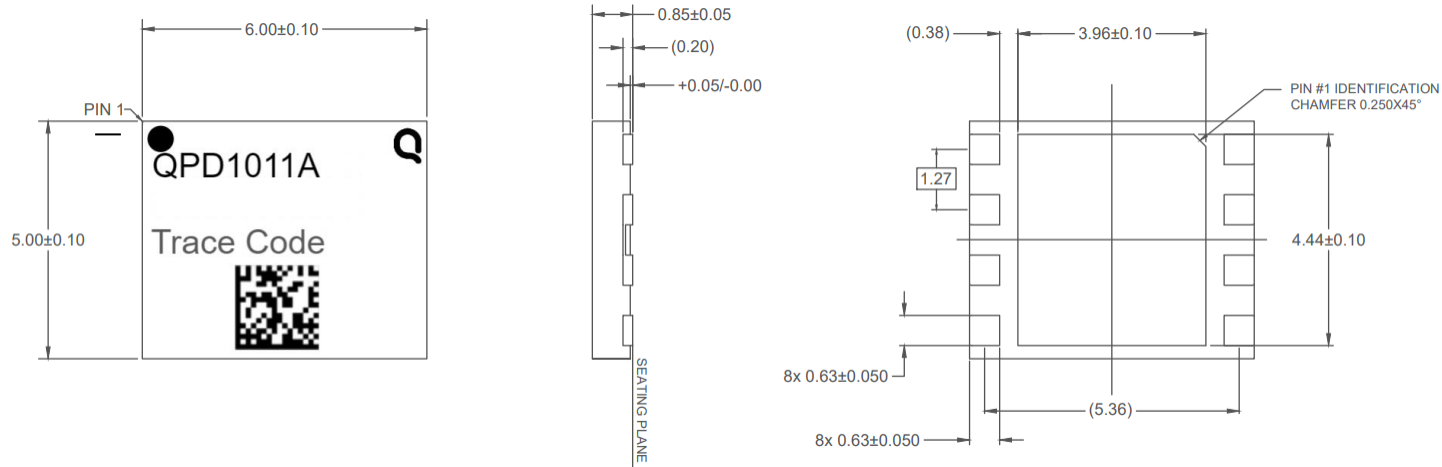


## 12. Packaging and Ordering Information

### 12.1. Device Marking and Package Dimensions

Marking: Part number – QPD1011A

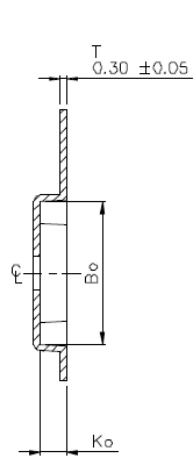
Trace code – QR Code Format



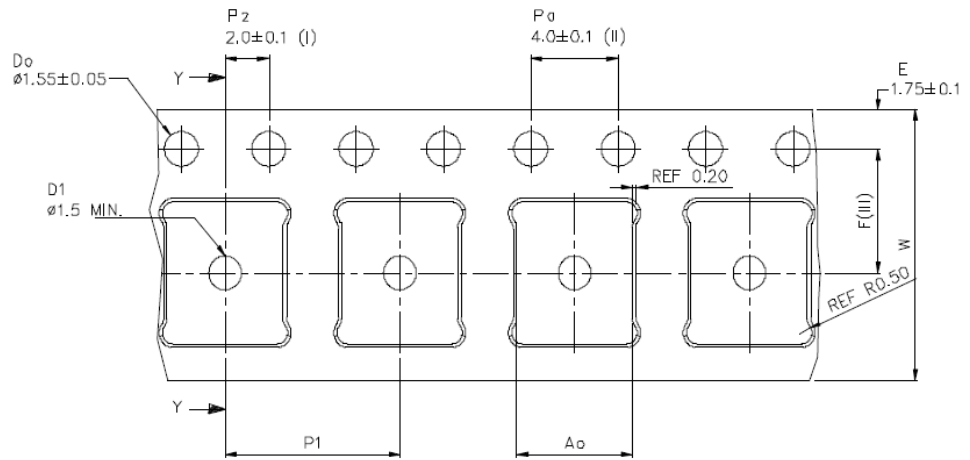
Notes:

1. Package leads are gold plated.
2. Part is mold encapsulated.
3. All units are in millimeter.

### 12.2. Tape and Reel Information



SECTION Y-Y



$A_o$	$5.30 \pm 0.1$
$B_o$	$6.30 \pm 0.1$
$K_o$	$1.20 \pm 0.1$
$F$	$5.50 \pm 0.1$
$P_1$	$8.00 \pm 0.1$
$W$	$12.00 \pm 0.3$

- (I) Measured from centreline of sprocket hole to centreline of pocket.
- (II) Cumulative tolerance of 10 sprocket holes is  $\pm 0.20$ .
- (III) Measured from centreline of sprocket hole to centreline of pocket.
- (IV) Other material available.

ALL DIMENSIONS IN MILLIMETRES UNLESS OTHERWISE STATED.

## 13. Handling Precautions

Parameter	Rating	Standard
ESD – Human Body Model (HBM)	250V	ANSI/ESD/JEDEC JS-001
ESD – Charged Device Model (CDM)	1000V	ANSI/ESD/JEDEC JS-001
MSL – Moisture Sensitivity Level	Level 3	JESD J-STD-020



**Caution!**

ESD sensitive device

## 14. Solderability

Compatible with both lead-free (260 °C max. reflow temperature) and tin/lead (245 °C max. reflow temperature) soldering processes.

Contact Plating: NiPdAu

## 15. Environmental Compliance

This part is compliant with the 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment), as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- SVHC Free
- PFOS Free





## 16. Revision History

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Revision	Description
A	Datasheet Release



# QPD1011A

## 7W, 50V, 30 – 1200MHz, GaN Input Matched Transistor

### Contact Information

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For the latest specifications, additional product information, worldwide sales and distribution locations:

**Web:** [www.qorvo.com](http://www.qorvo.com)

**Tel:** +1 844-890-8163

**Email:** [customer.support@qorvo.com](mailto:customer.support@qorvo.com)

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